



E. Berdermann, M. Ciobanu, M. Fischer, J. Frühauf, S. Gsell, M. Kiš,
W. Koenig, P. Moritz, MD. S. Rahman, M. Schreck, C. Stehl and M. Träger

CARAT RESULTS FROM DIAMOND-ON-IRIDIUM (DOI) SENSORS

OUTLINE

- INTRODUCTION - OBJECTIVES
- MATERIAL and SENSOR CHARACTERIZATION
 - INTRINSIC Dia-On-Ir (DOI) SAMPLES: 2009, 2010, 2011
 - DEFECTS, DARK CONDUCTIVITY, CHARGE COLLECTION EFFICIENCY, ALPHA-TOF, BEAM-TESTS
- SUMMARY
- CONCLUSIONS and OUTLOOK

THE OBJECTIVES

- ρ Engineering of CVD DOI plates for sensor applications
 - crystal growth and post processing; defect characterization
- ρ Electronic properties and DOI- Detector performance
 - comparison of all three 'detector-grade' CVDD types
- ρ FEE developments
 - Broadband amplifiers and discriminators - single-channel and ASICs - in particular, for fast MIP timing



Target: Large-area, advanced-diamond strip sensors of low material budget for tracking and ToF of HI + MIP

CVD DIAMOND-ON-IRIDIUM (DOI)

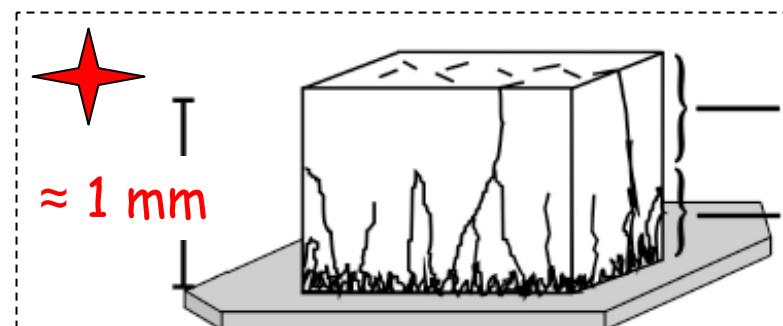
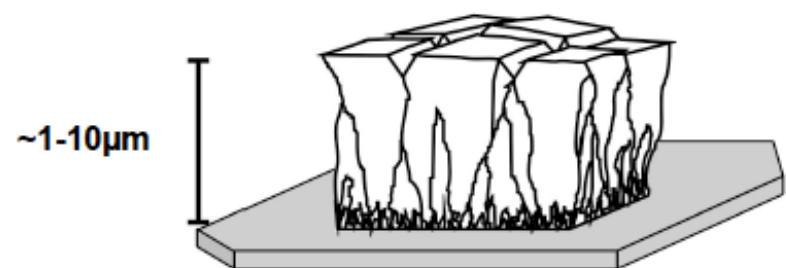
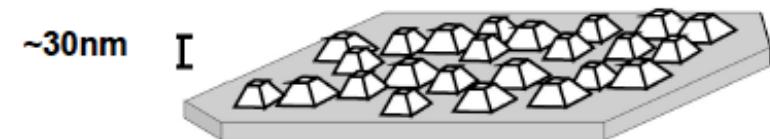
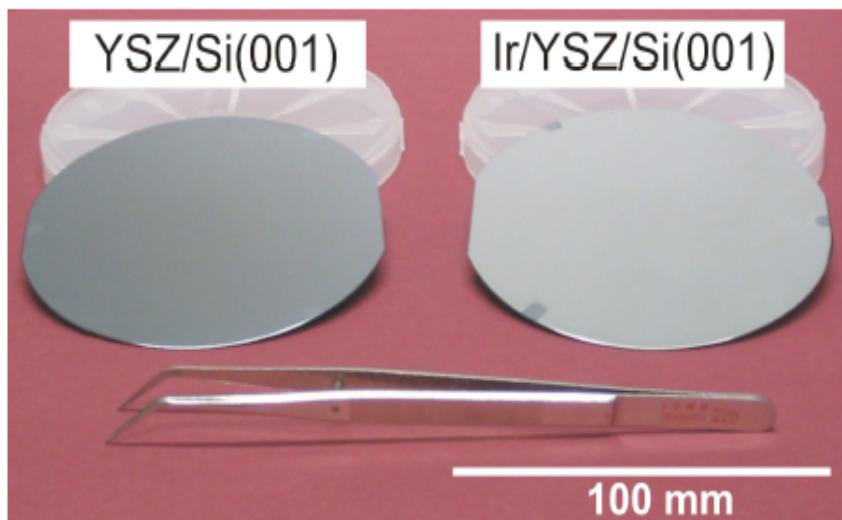
WAFER-SCALE SINGLE-CRYSTAL
DIAMOND DETECTORS

UA: S. Gsell et al.,
Appl. Phys. Lett. 84 (2004)

BY HETEROEPITAXY



on large-area iridium
substrates (CVD-DOI)



FINAL SUBSTRATE STRUCTURE

CARAT results from diamond-on-iridium (DOI) sensors

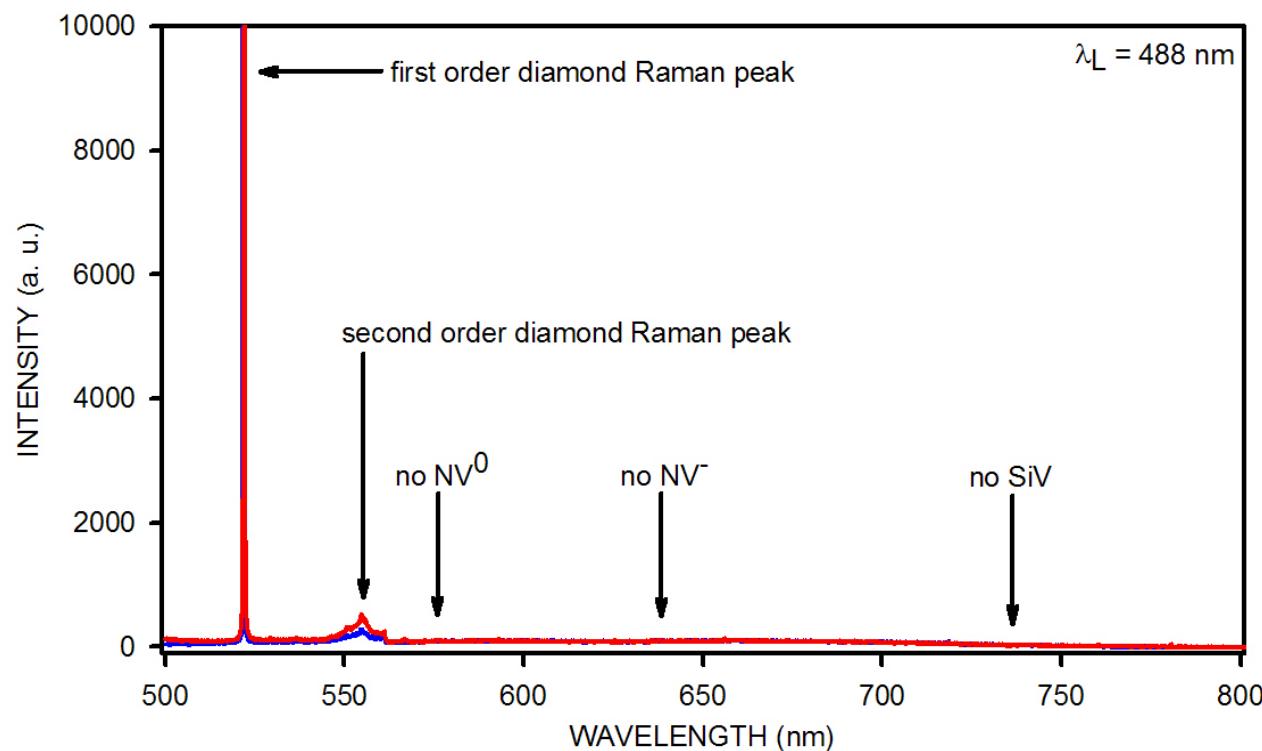
DEFECT SPECTROSCOPY

NITROGEN and
SILICON IMPURITIES



UA: C. Stehl, M. Schreck, M. Fischer

Photoluminescence of sample MFDIA886
two different positions on growth side



No SiV and NV peaks visible

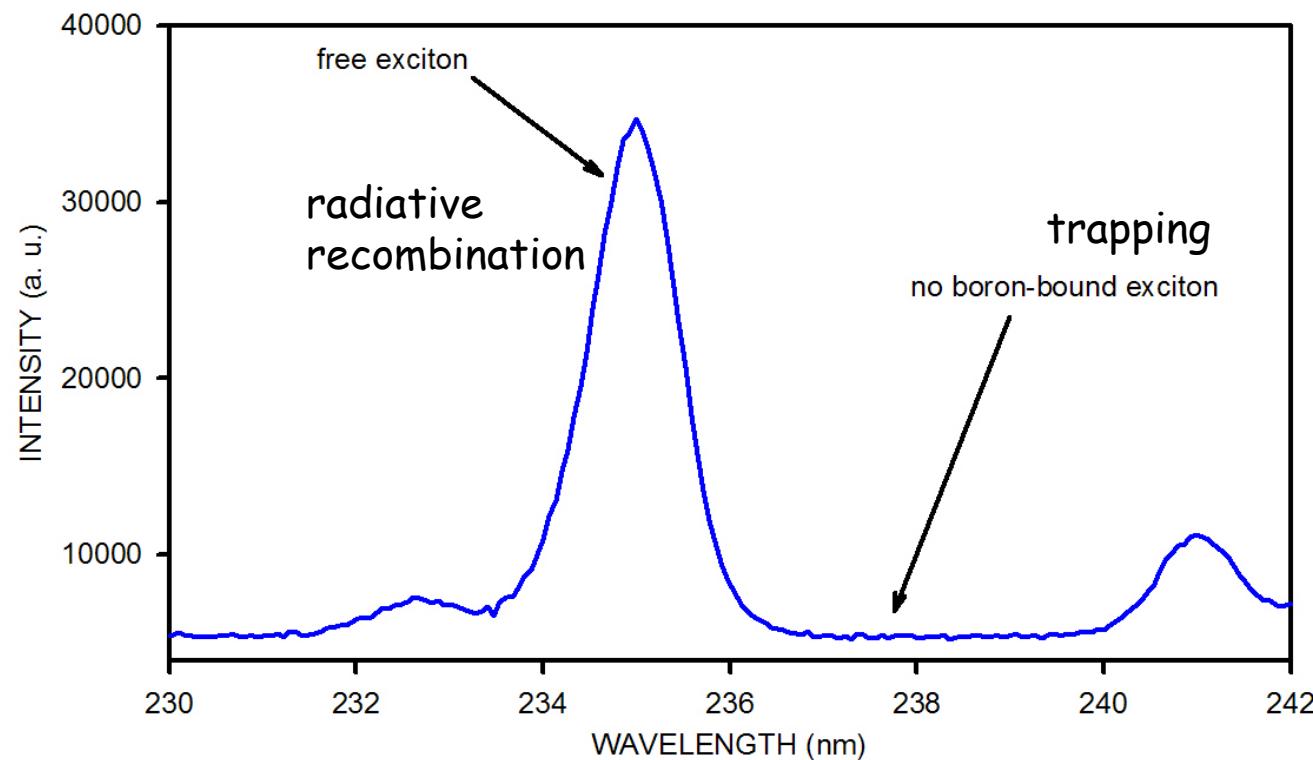
DEFECT SPECTROSCOPY

BORON IMPURITIES



UA: C. Stehl, M. Schreck, M. Fischer

Cathodoluminescence of sample CSDIA018



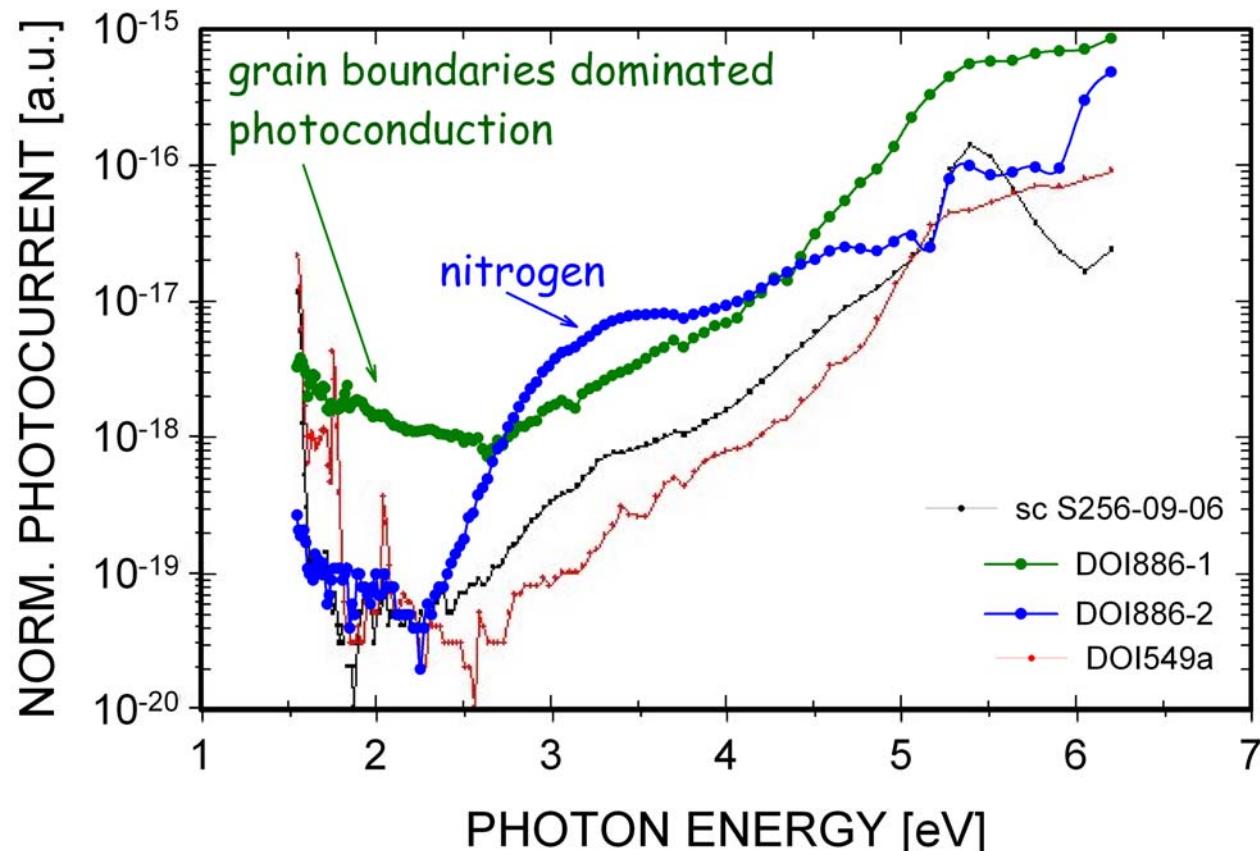
→ Boron concentration $\leq 1 \times 10^{14} \text{ cm}^{-3}$ (\approx measurement limit)

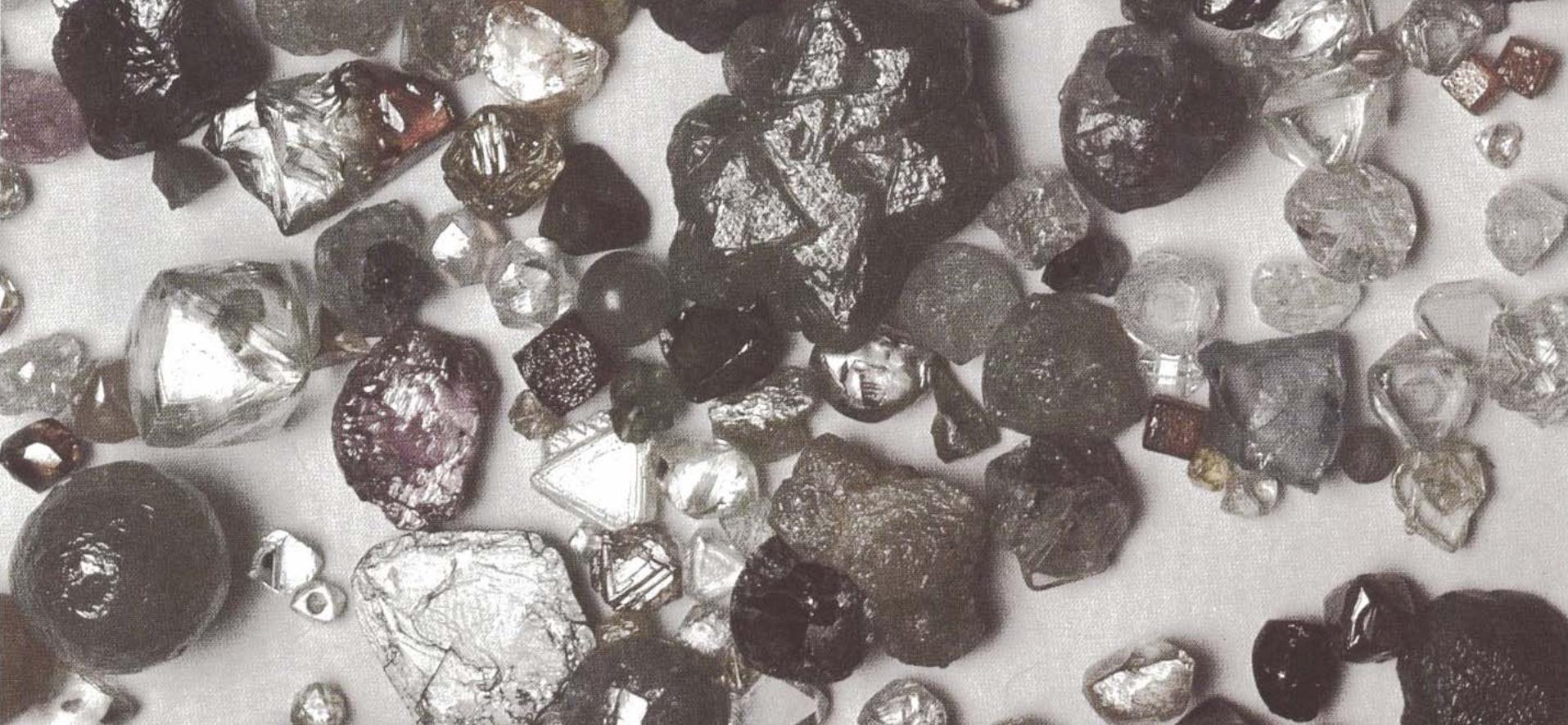
DEFECT SPECTROSCOPY

SPECTRALLY RESOLVED
PHOTOCURRENTS

→ IAF: E. Layevski, C. Nebel

2010



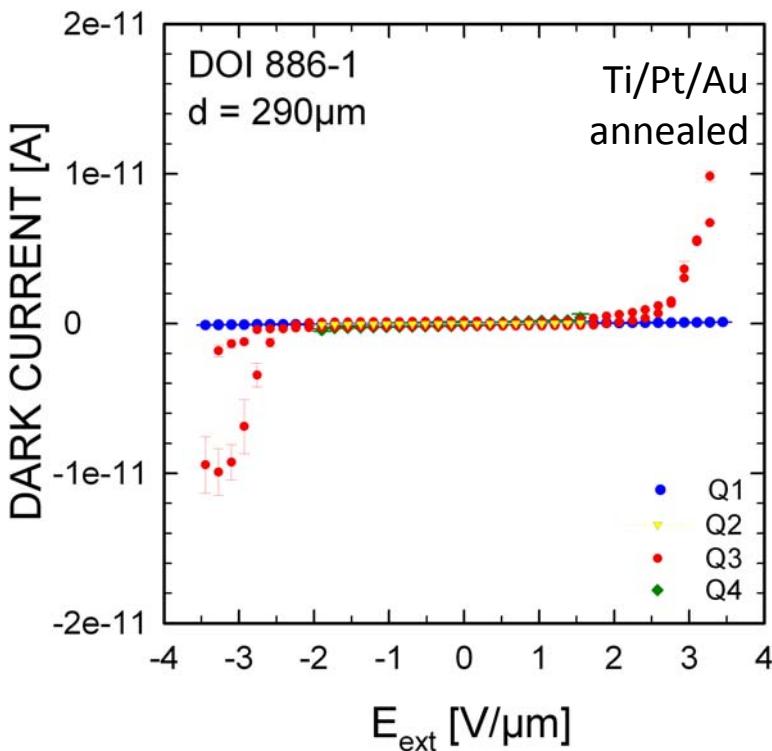


DETECTOR PROPERTIES

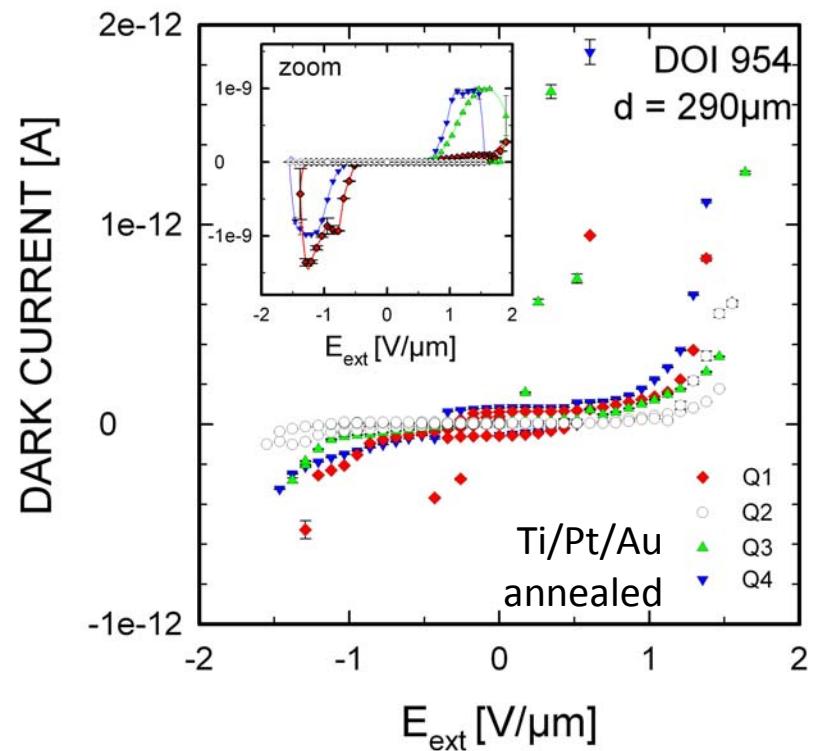
DARK CONDUCTIVITY

LOW I_{Dark} : COMPENSATION OF TRAPS → GSI: M. Träger, S. Rahman

QUADRANT- SENSOR
SPATIAL HOMOGENEITY



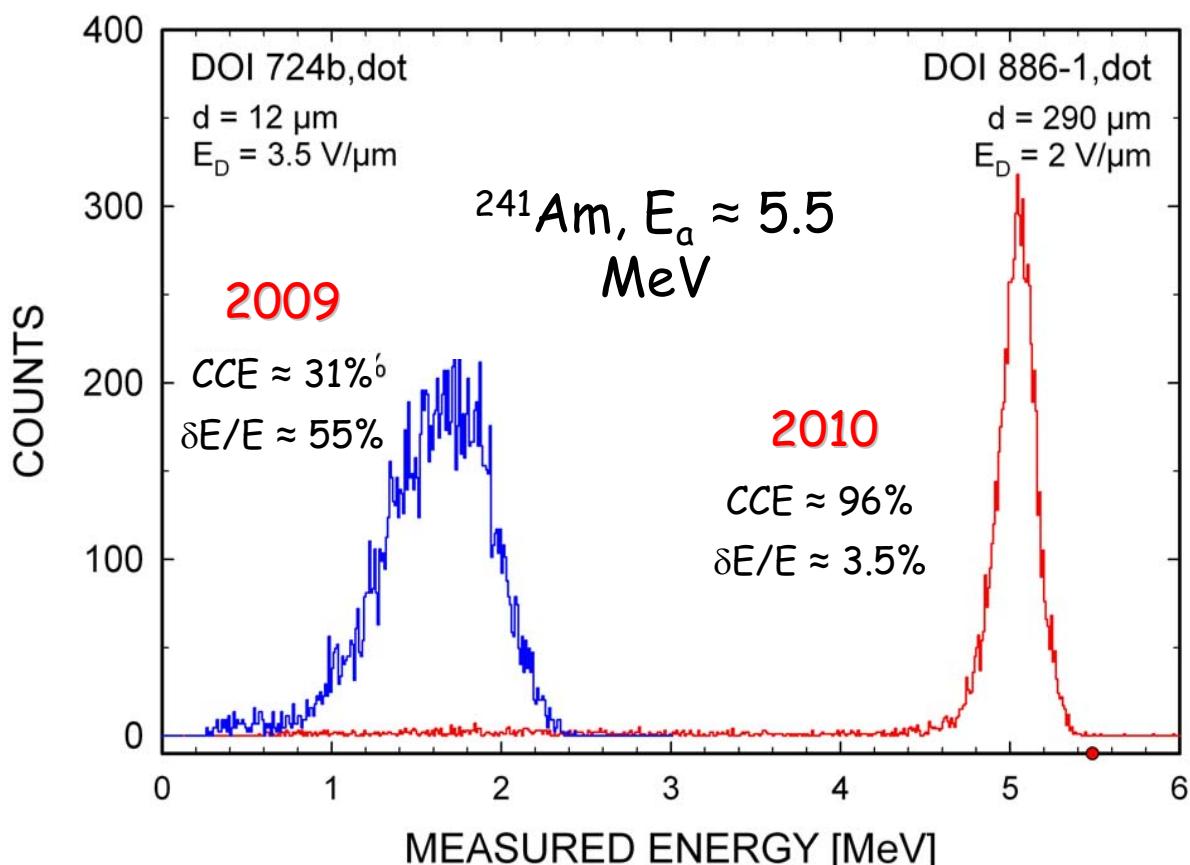
QUADRANT-SENSOR
SPATIAL HOMOGENEITY



Q-COLLECTION PROPERTIES



GSI: M. Träger, S. Rahman, EBe



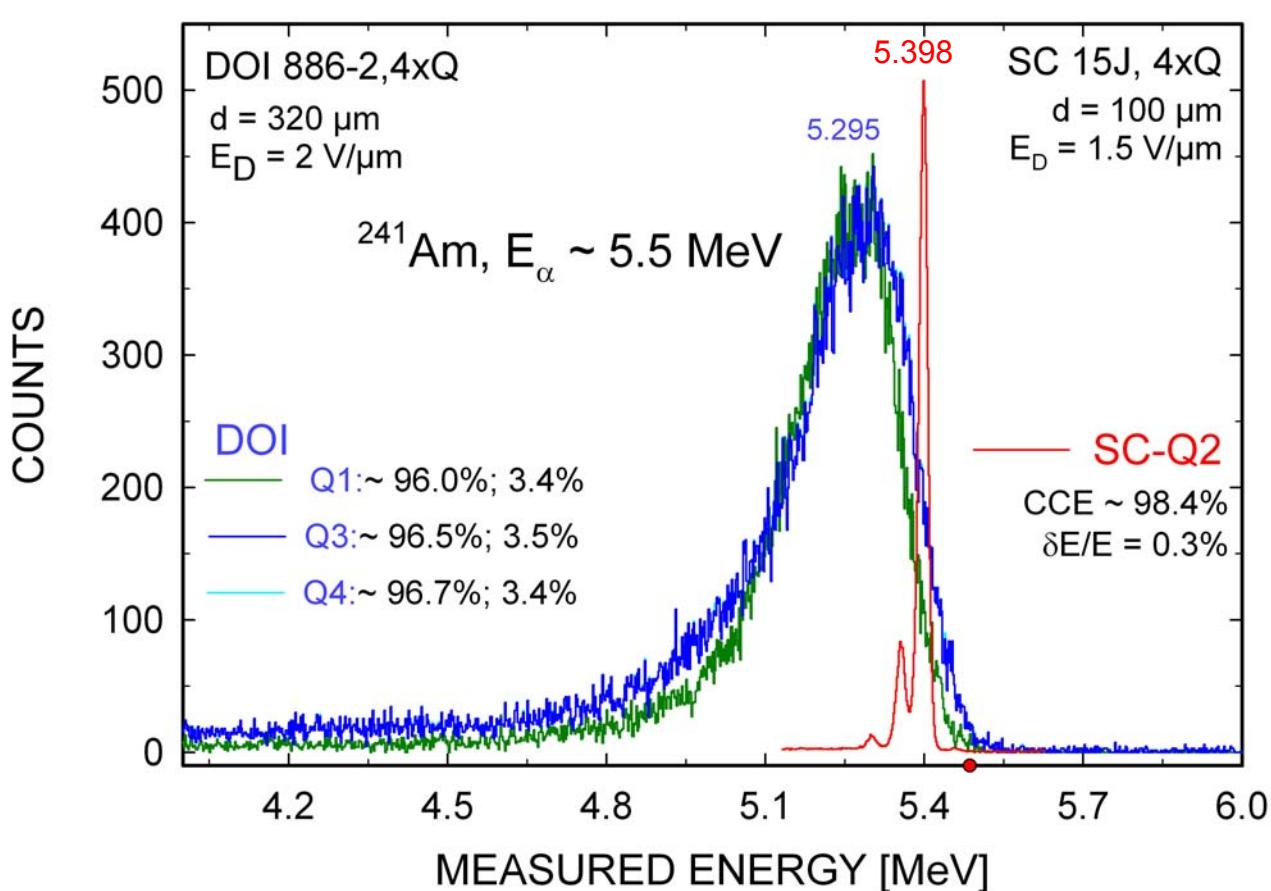
RAPID
PROGRESS
IN CCE

Q-COLLECTION PROPERTIES

- DOI STARTS TO BEHAVE as HSC-CVDD

→ CCE : HSC - 2.5%
 $\delta E/E$: HSC + 3%

2010



IMPROVING
ENERGY
RESOLUTION

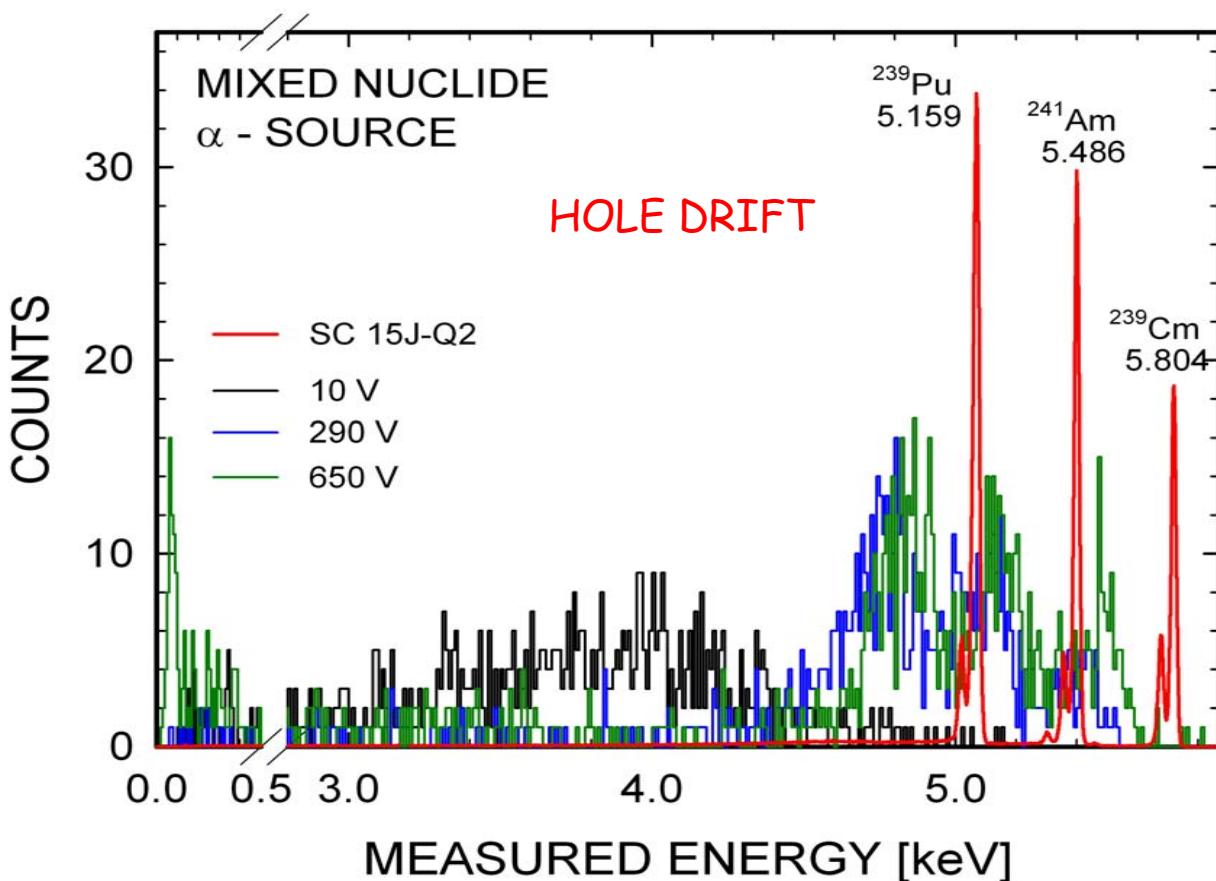
Q-COLLECTION PROPERTIES

➤ CCE + ENERGY RESOLUTION



$CCE_{h\text{-drift}} \approx 93\%$
 $\delta E/E \approx 1.5\%$

2011

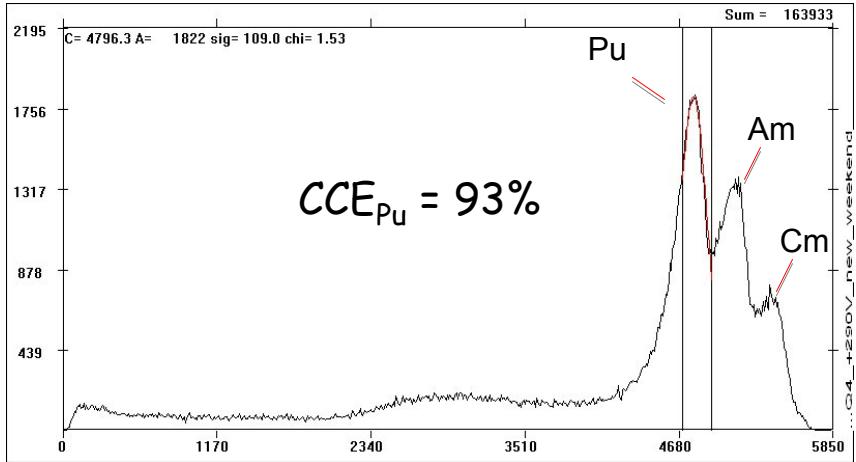


TOWARDS
SPECTROSCOPIC
GRADE
DIAMOND

Q-COLLECTION PROPERTIES

► DEVICE STABILITY OVER WEEKEND

→ GSI

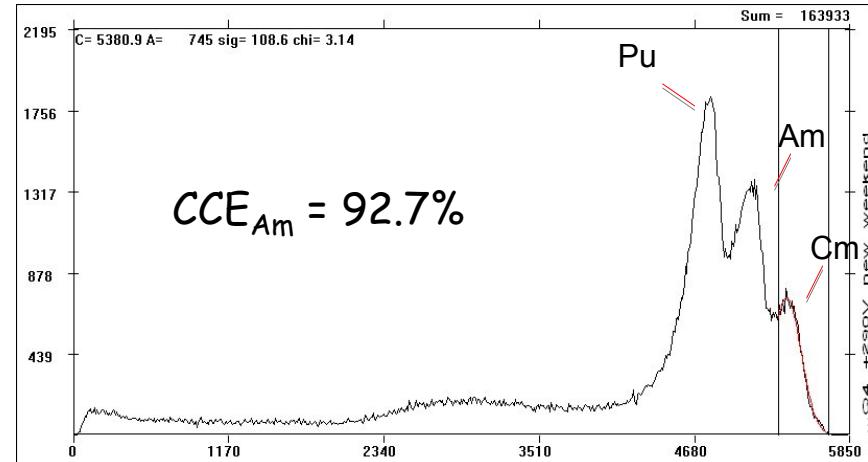
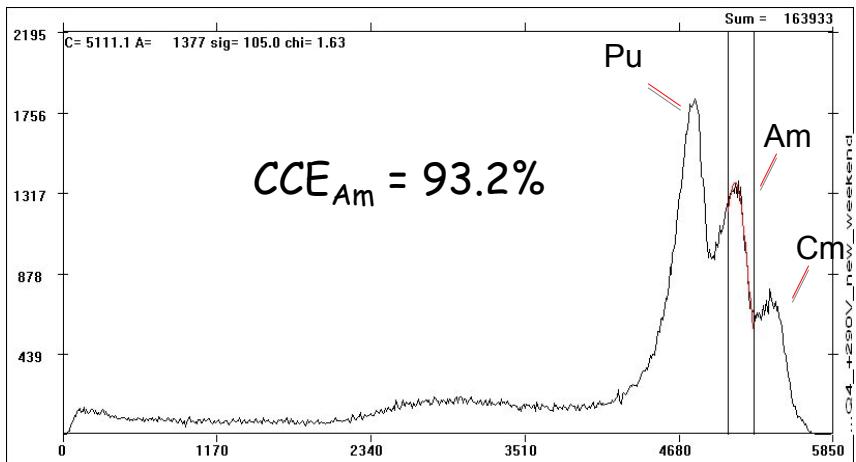


2011

HOLE DRIFT DATA

@ 400V

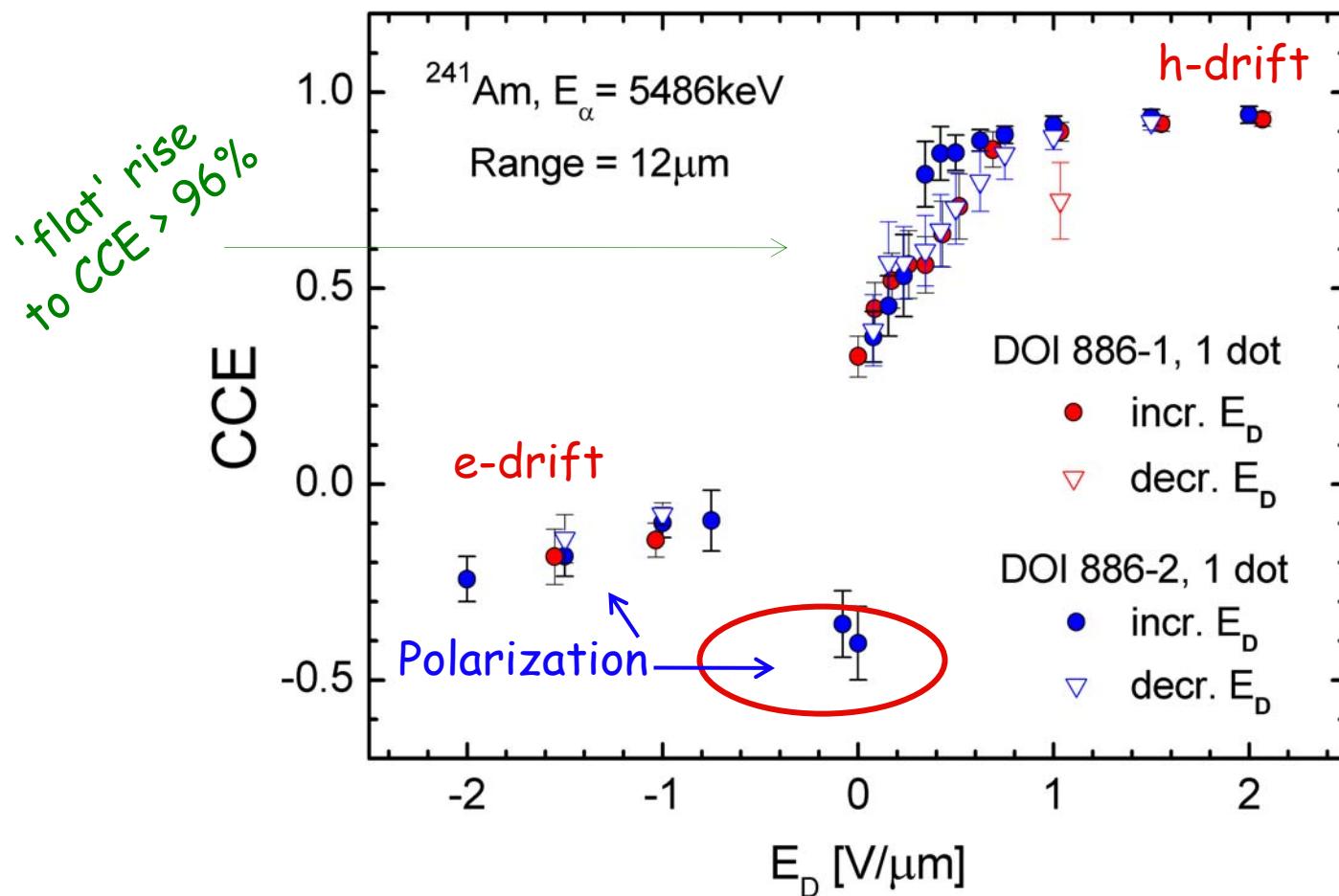
$CCE_{h\text{-drift}} \approx 93\% \text{ (initially pumped)}$



Q-COLLECTION PROPERTIES

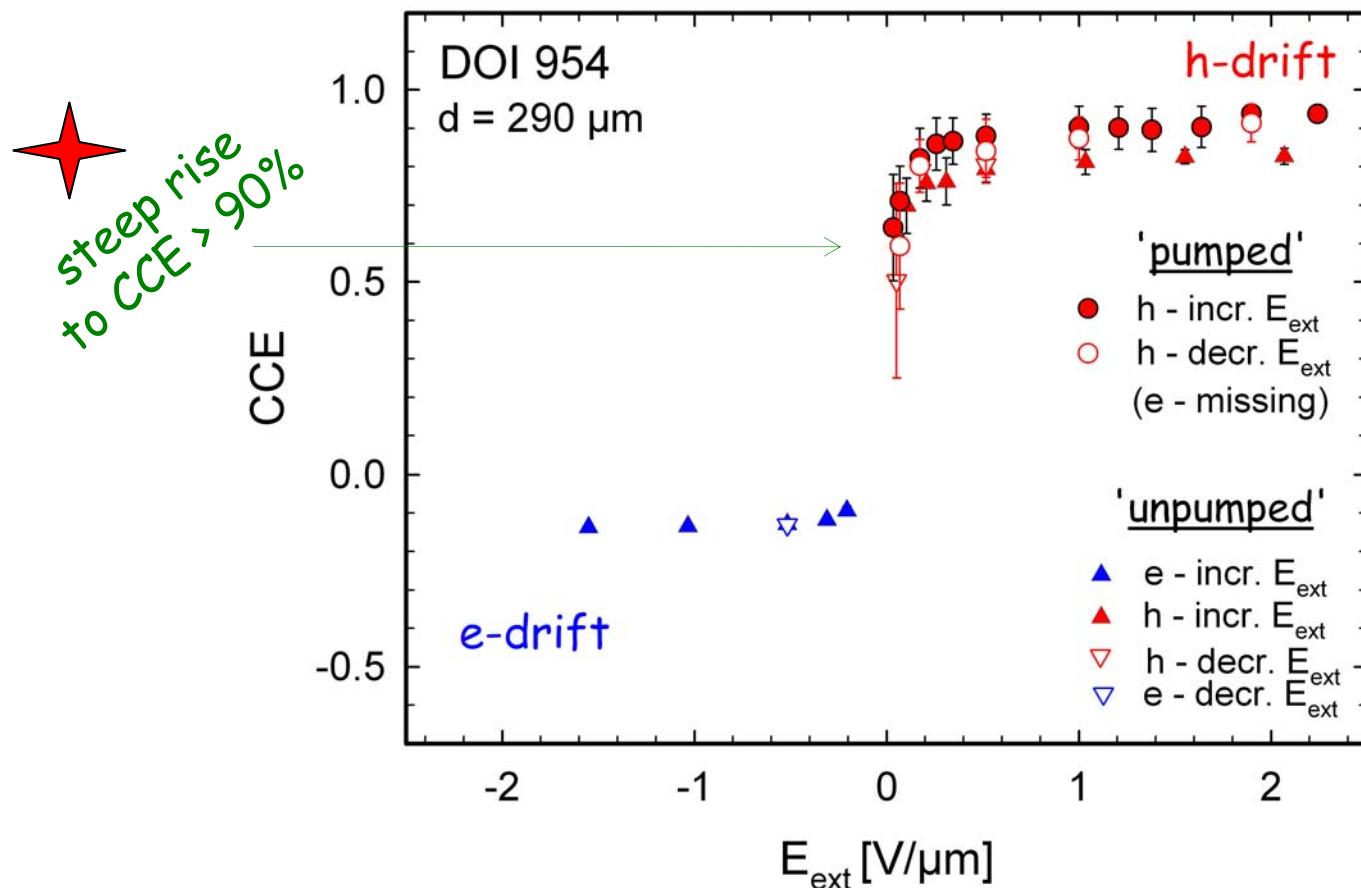
➤ COLLECTION EFFICIENCY ➔ 2010

$CCE_{h\text{-drift}} \approx 96\%$
 $CCE_{e\text{-drift}} < 30\%$



Q-COLLECTION PROPERTIES

- COLLECTION EFFICIENCY ➔ 2011 GSI: $CCE_{h\text{-drift}} \approx 93\%$ (pumped)
 $CCE_{e\text{-drift}} \approx 13\%$ (unpump.)



Q-COLLECTION PROPERTIES

2nd DOI DELIVERY 2011

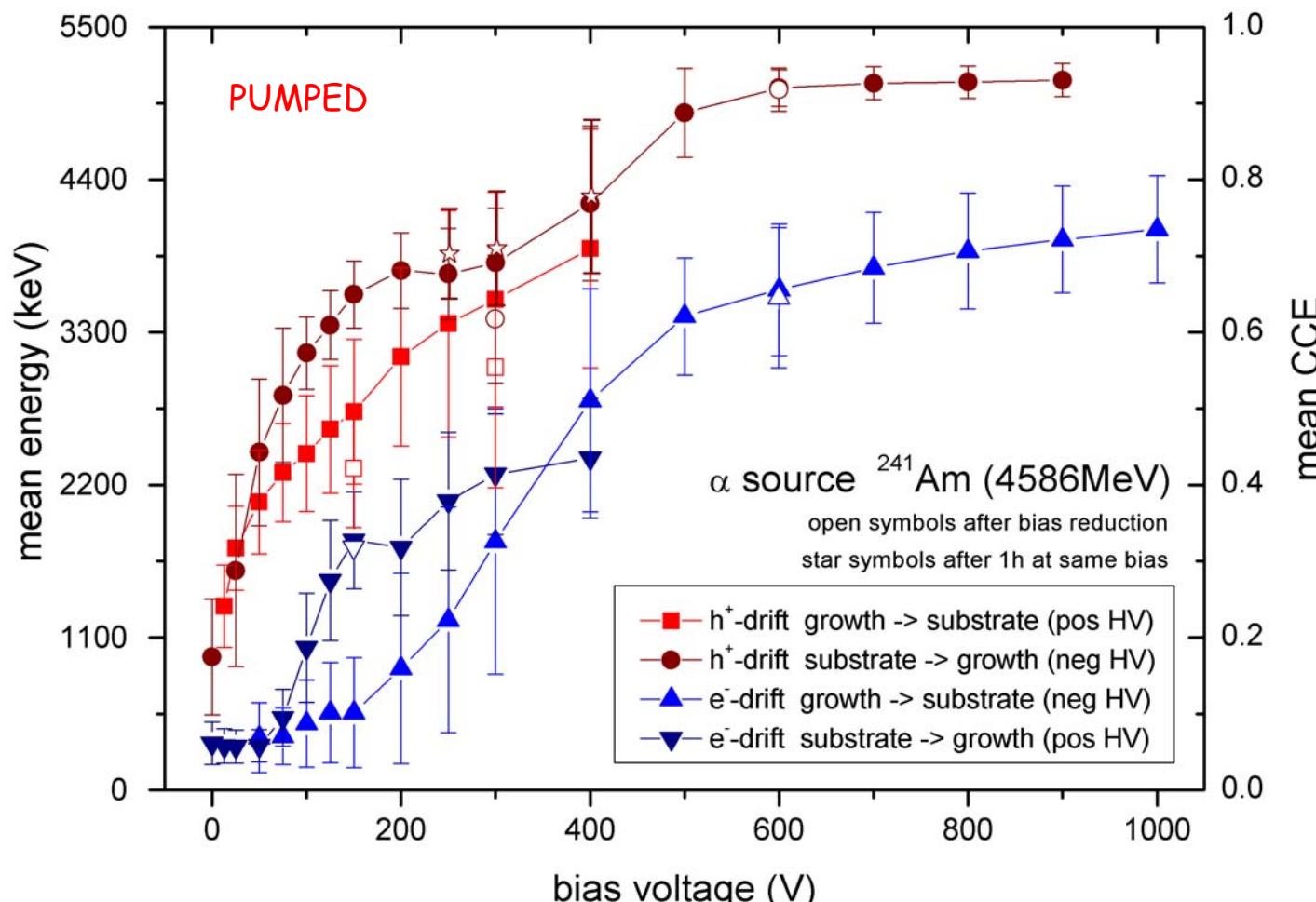
→ M. Träger, GSI

VERY RECENT DATA

CCE measurement of DOI MFDia955-1 (260μm)

11/2011

Sr-90 pumped: 5min @ +250V + 3h40min @ -250V

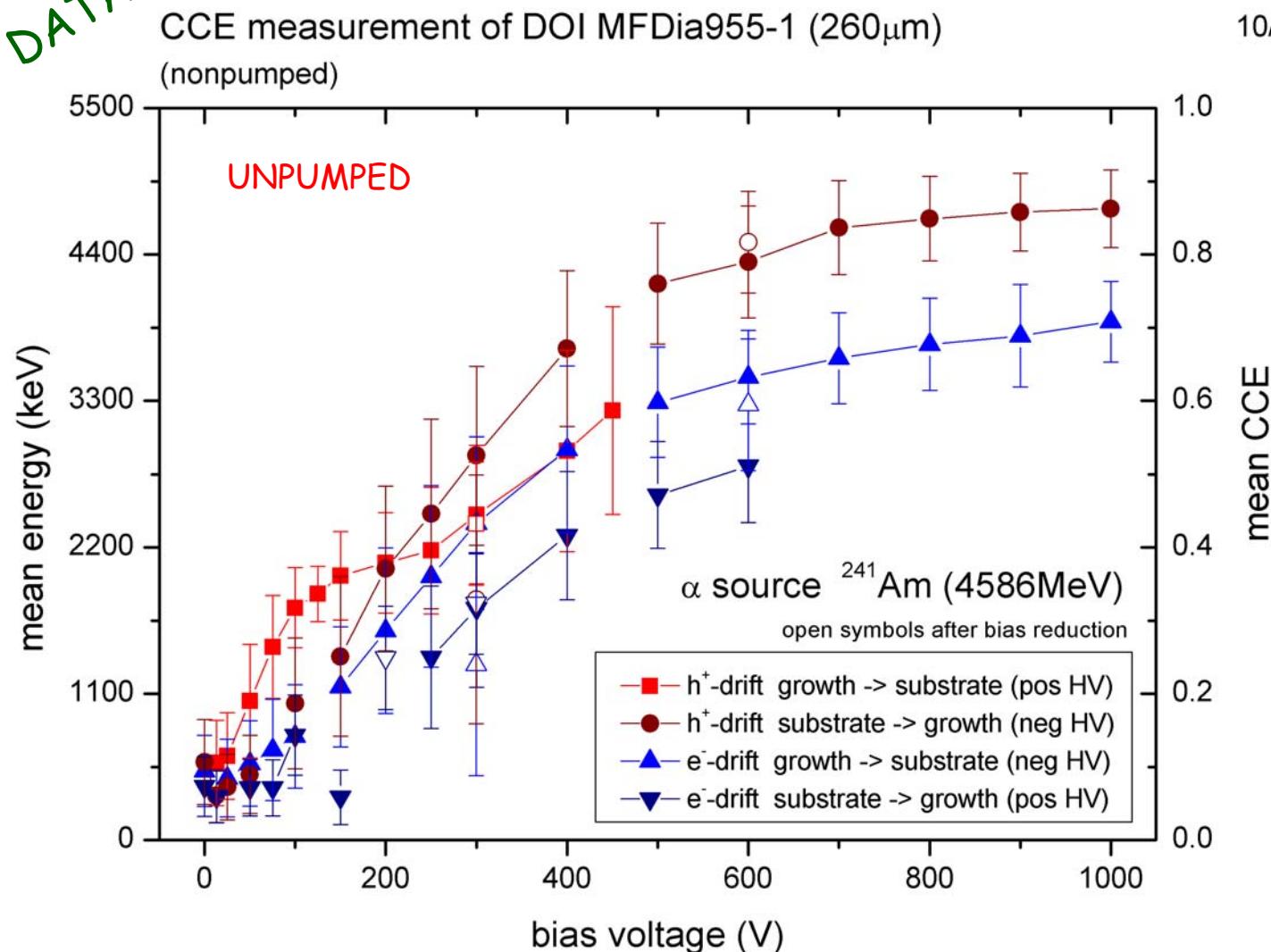


Q-COLLECTION PROPERTIES

2nd DOI DELIVERY 2011

→ M. Träger, GSI

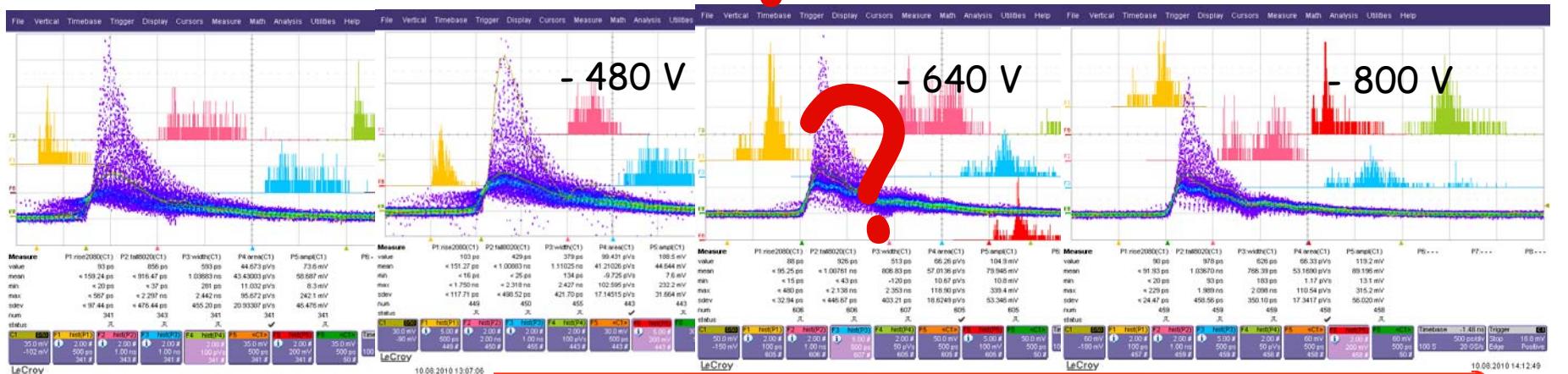
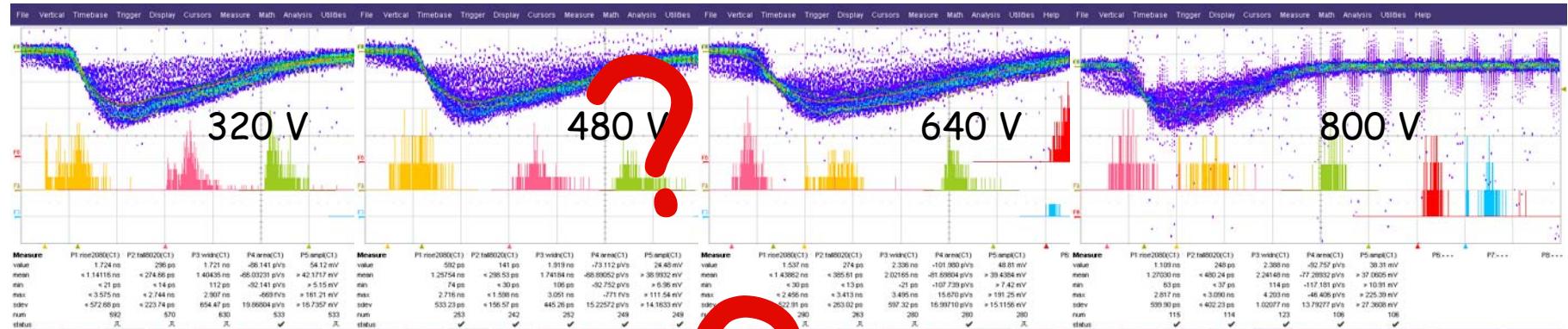
VERY RECENT DATA



INTERNAL FIELD PROFILE - TCT

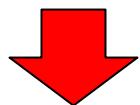
TRANSPORT PARAMETERS → 2010

GSI: M. Traeger, S. Rahman, EBe





TRAPPING and RELEASE ?



trapping \approx nanoseconds (BB-FEE);
release and collection \approx order of microseconds
(shaping constant of shaping amplifier)

INTERNAL FIELD PROFILE - TCT

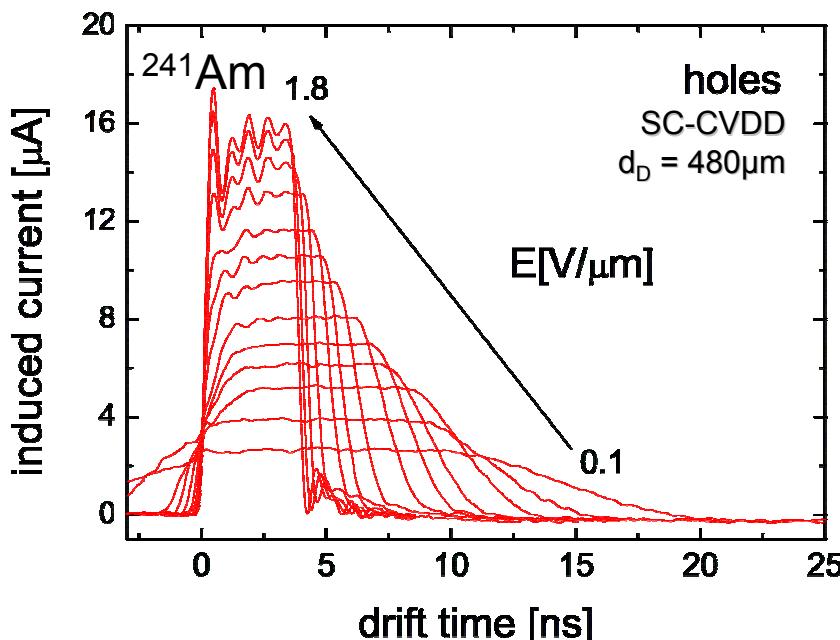
TRANSPORT PARAMETERS



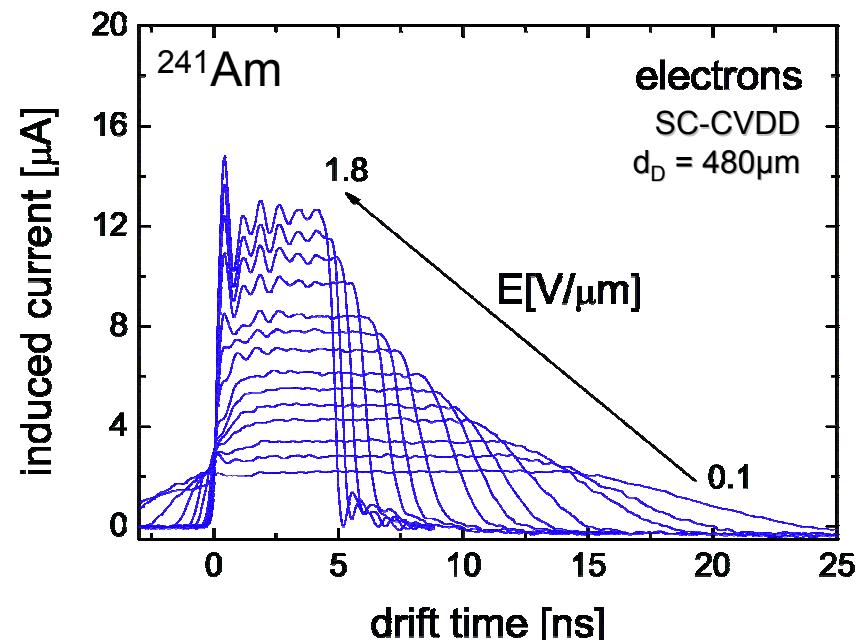
Michał Pomorski, PhD thesis, Univ. of Frankfurt (2008)

REMINDER!

DEFECT-FREE HOMOEPITAXIAL SC-CVDD



$$v_{\text{Drift}} \geq 120 \text{ } \mu\text{m/ns}$$

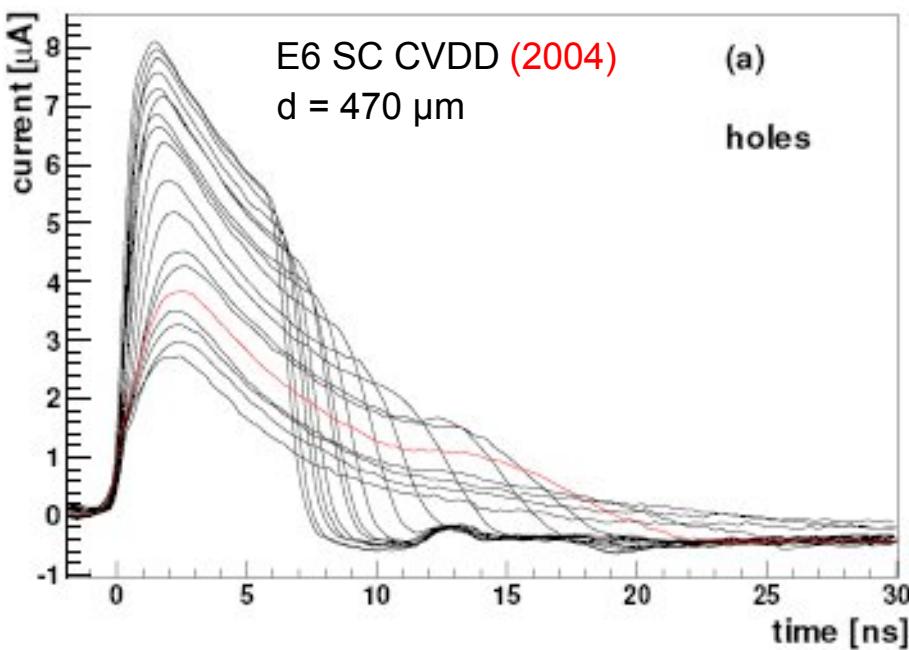


$$v_{\text{Drift}} \geq 100 \text{ } \mu\text{m/ns}$$

INTERNAL FIELD PROFILE - TCT

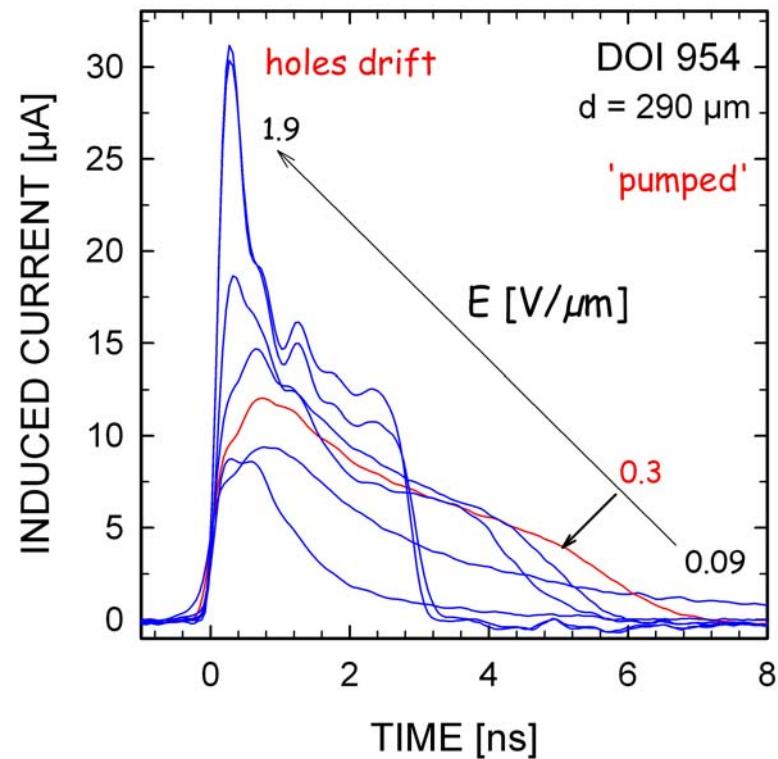
TRANSPORT PARAMETERS COMPARED

'EARLY' HOMOEPITAXIAL SC-CVDD



H. Pernegger, J. Appl. Phys. 97 073704 (2005)

DOI 2011



CARAT results from diamond-on-iridium (DOI) sensors

TIMING PROPERTIES - TCT

TRANSPORT PARAMETERS COMPARED (HOLE DRIFT)

PRELIMINARY DRIFT VELOCITY

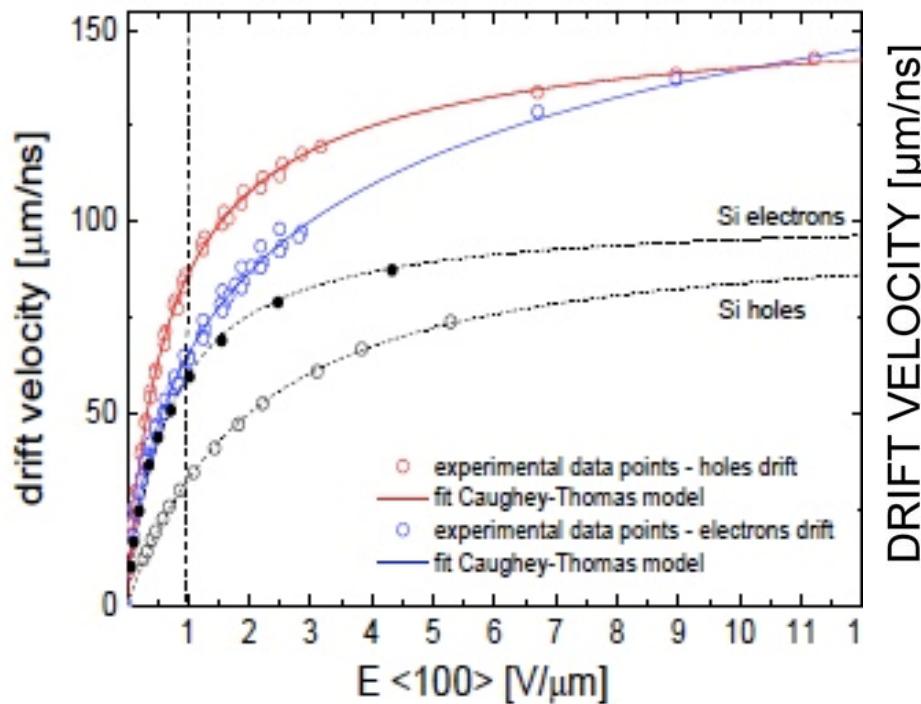
DIAM - TYPE	E_D [V/ μ m]	v_{DRIFT} [cm/s]
CVD DOI	1.0	7.5×10^6
..	2.0	1.0×10^7
HSC CVDD	2.0	1.6×10^7

$$v_{DRIFT} = d_D / t_{Tr}$$

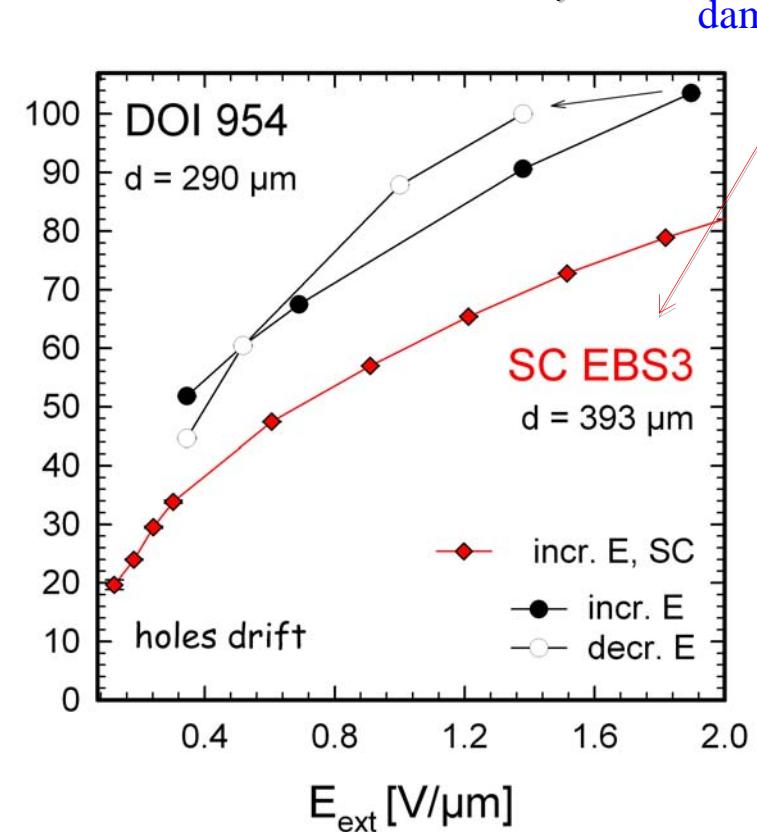
DRIFT VELOCITY - HOLES

TRANSPORT PARAMETERS COMPARED

DOI HOLE DRIFT DATA (PRELIMINARY!)



Michał Pomorski PhD thesis (2008)

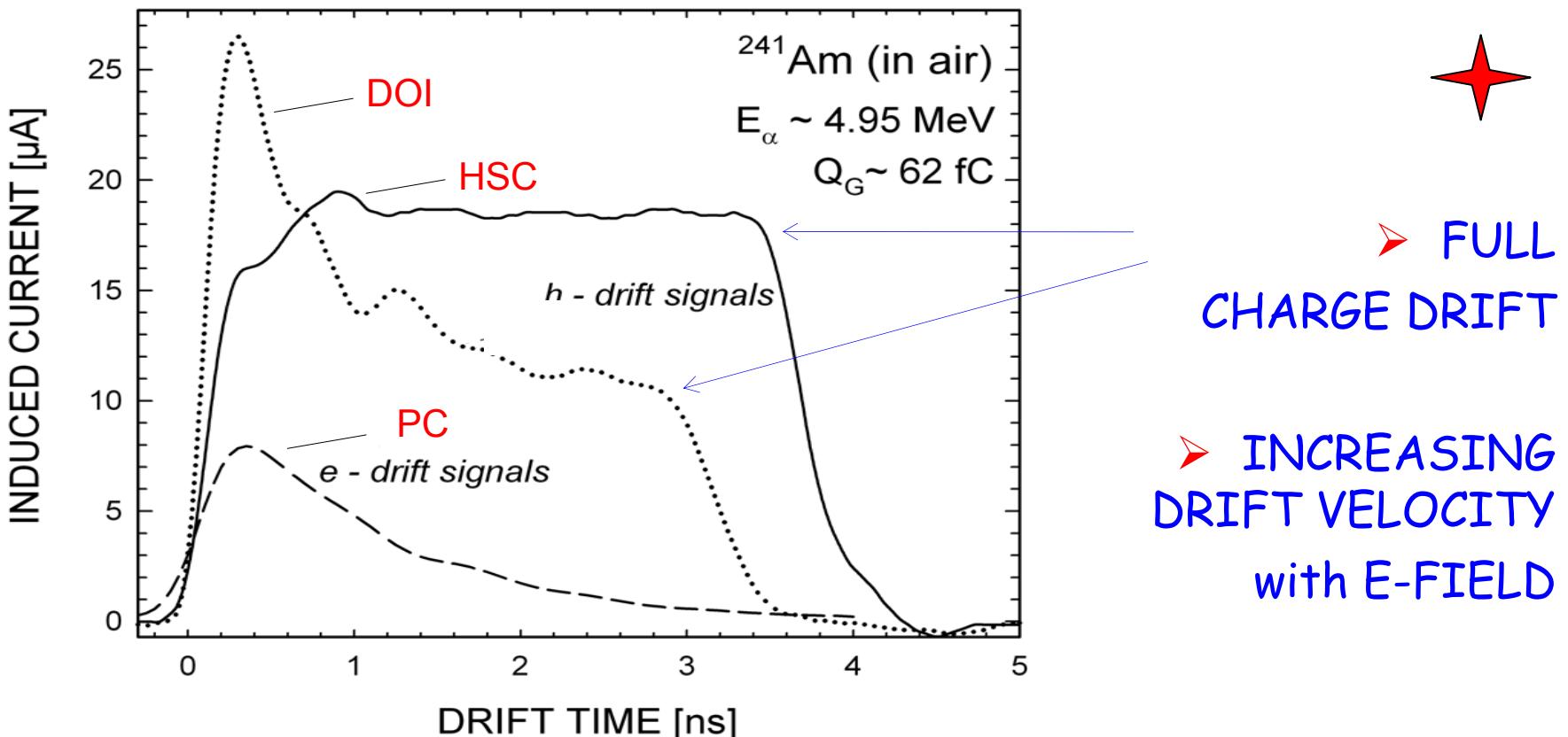


damaged !

INTERNAL FIELD PROFILE - TCT

TRANSPORT PARAMETERS COMPARED

ALL THREE DETECTOR-GRADE CVDD TYPES



INTERNAL FIELD PROFILE - TCT

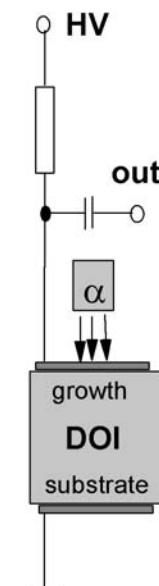
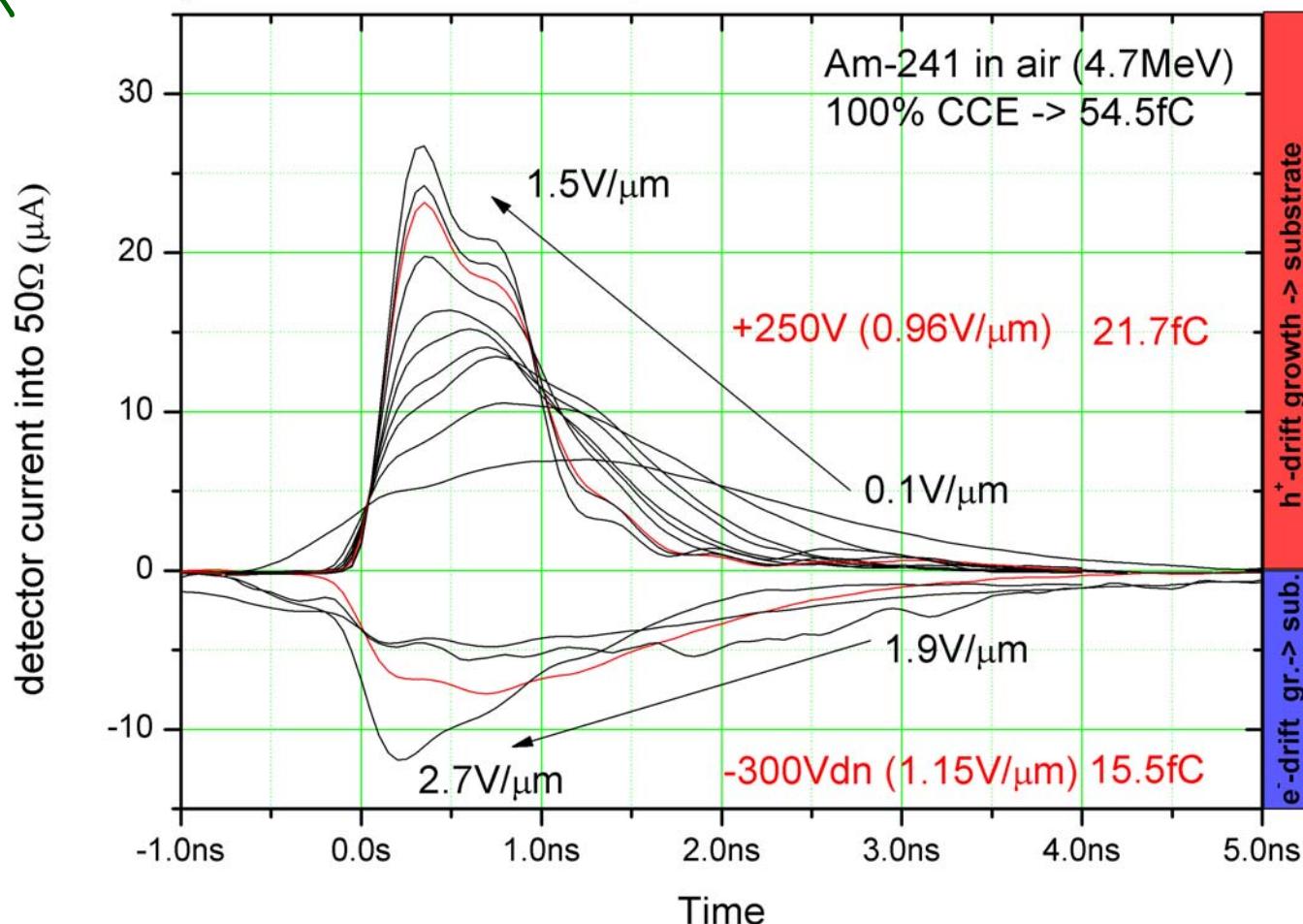
2nd DOI DELIVERY 2011

→ M. Träger, GSI

VERY RECENT DATA

MFDia955-1 (260μm) average BB signals (^{90}Sr pumped)
(metallization: 1dot Al d=2.7mm)

11/2011

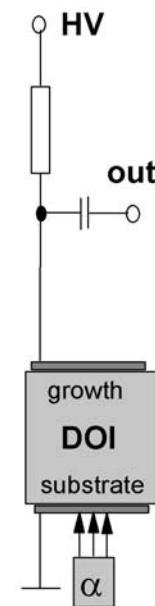
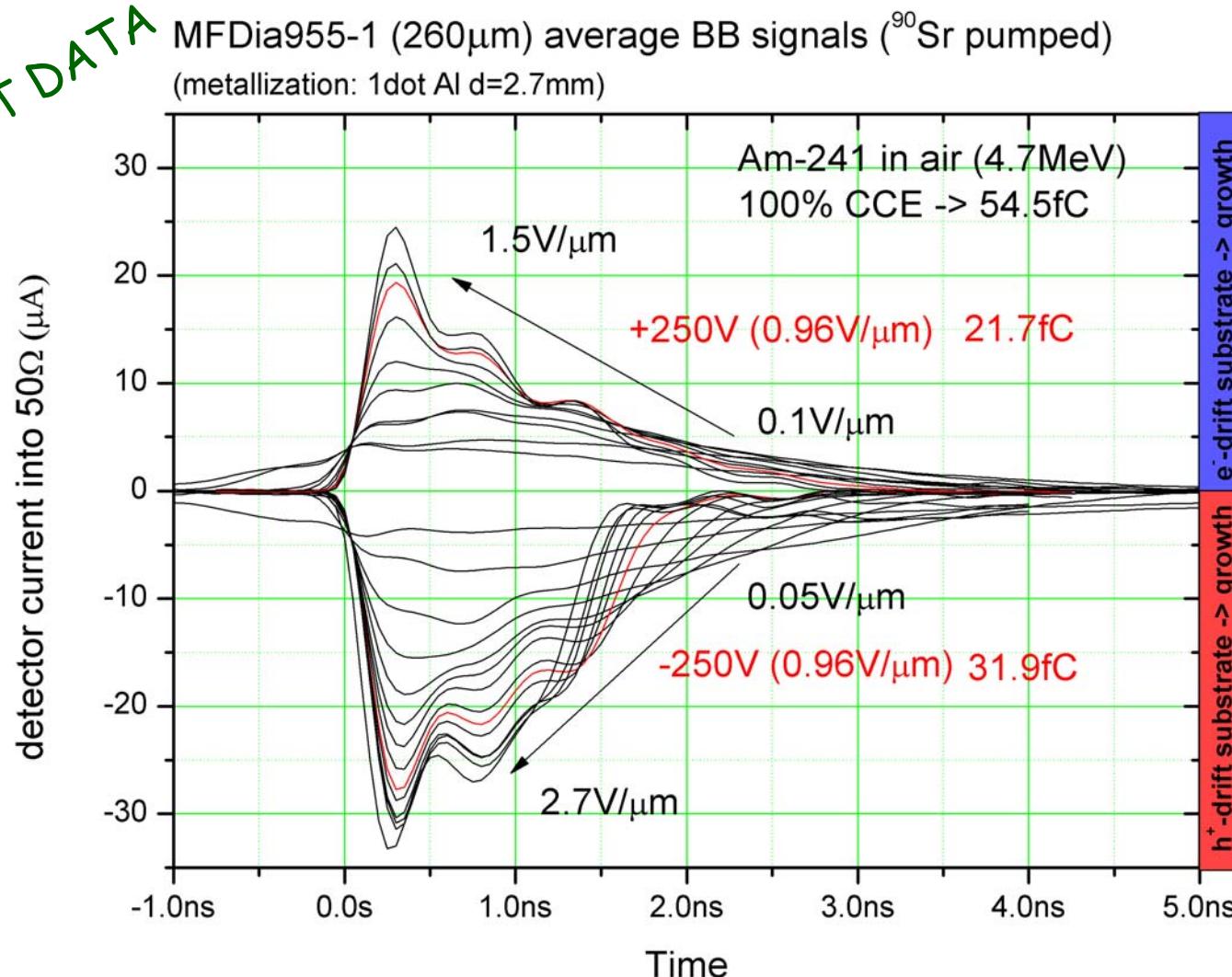


INTERNAL FIELD PROFILE - TCT

2nd DOI DELIVERY 2011

→ M. Träger, GSI

VERY RECENT DATA

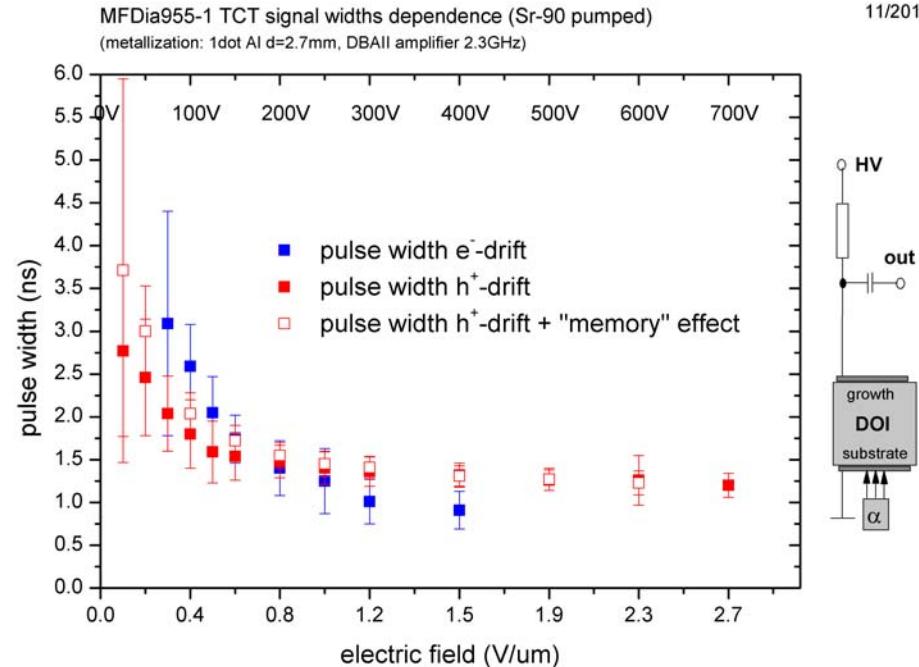
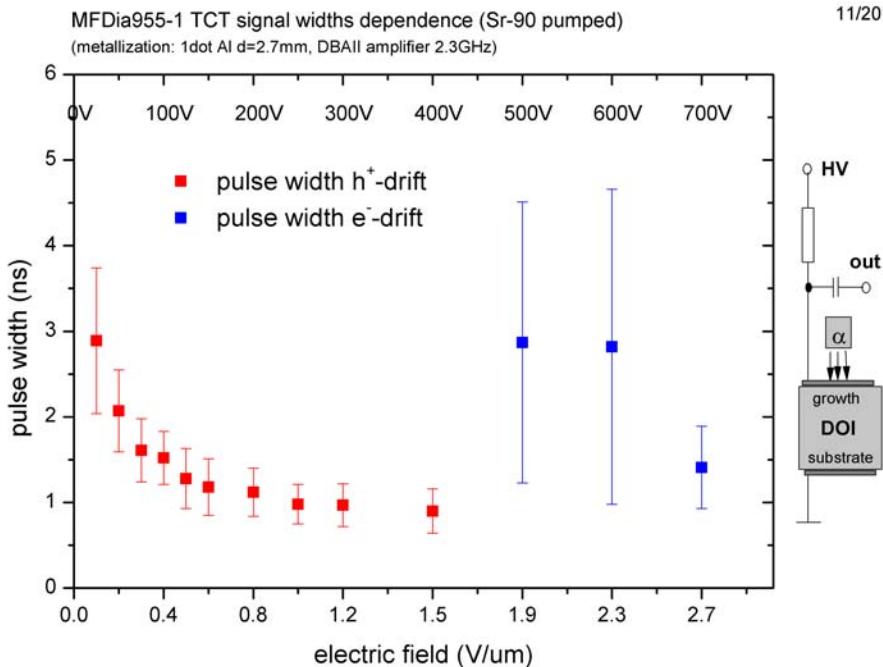


INTERNAL FIELD PROFILE - TCT

2nd DOI DELIVERY 2011

→ M. Träger, GSI

VERY RECENT DATA

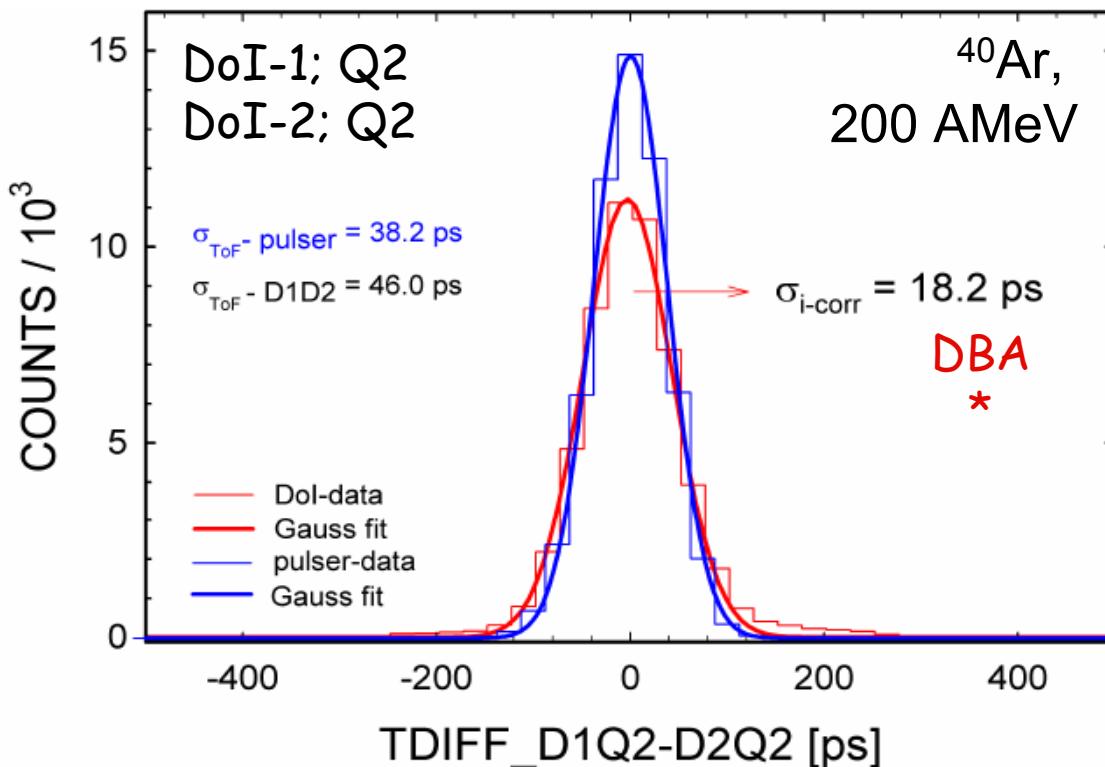


? better substrate side

BB ELECTRONICS

➤ TOF RESOLUTION
CONFIRMED
CVDD

→ SIMILAR TO PC and HSC



extended calculations
and simulations

M. Ciobanu et al., IEEE TNS 58
no. 4, 2073 (2011)

GSI: P. Moritz, M. Ciobanu, W. Koenig
M. Träger, S. Rahman, C. Stehl, EBe

SUMMARY

- ❑ CHARGE COLLECTION SIGNIFICANTLY IMPROVED
 - CCE: 90%-96%
 - $\delta E/E(\alpha's)$: 1.5%
- ❑ TIME RESOLUTION CONFIRMED
 - 20-25 ps
- ❑ FEE (BB) BETTER UNDERSTOOD
 - low-noise, low-capacitance setups
- ❑ NOT YET TESTED (ALTHOUGH POSSIBLE)
 - Larger area samples
 - Micro-strip sensors with PADI

CONCLUSIONS and OUTLOOK

- ❖ DOI is ALREADY a (DEFECTIVE) SINGLE CRYSTAL DIAMOND MATER.
 - BUT ONLY REGARDING THE HOLES
 - ELECTRON BEHAVIOR: NOT UNDERSTOOD
- ❖ NEXT STEPS TO DO
 - TO UNDERSTAND BETTER THE OBTAINED RESULTS
 - TO MINIMIZE THE DISLOCATION DENSITY
 - TO ENLARGE THE TEST SAMPLE AREA
 - TO USE PULSED UV-LASER FOR THE CHARACTERIZATION

LARGE-AREA DOI: EXAMPLE

Replacement of established neutron monochromator materials by diamond:

Established materials:

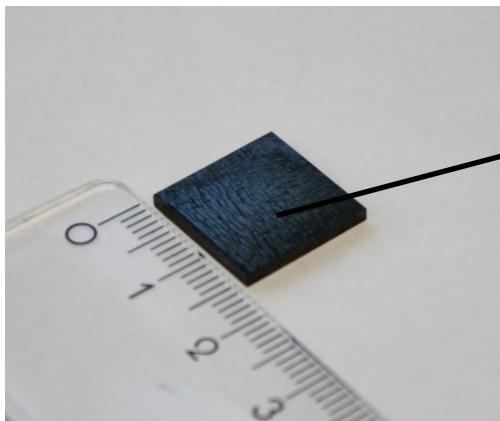
Graphite (HOPG), plastically deformed
Ge, Cu, Si



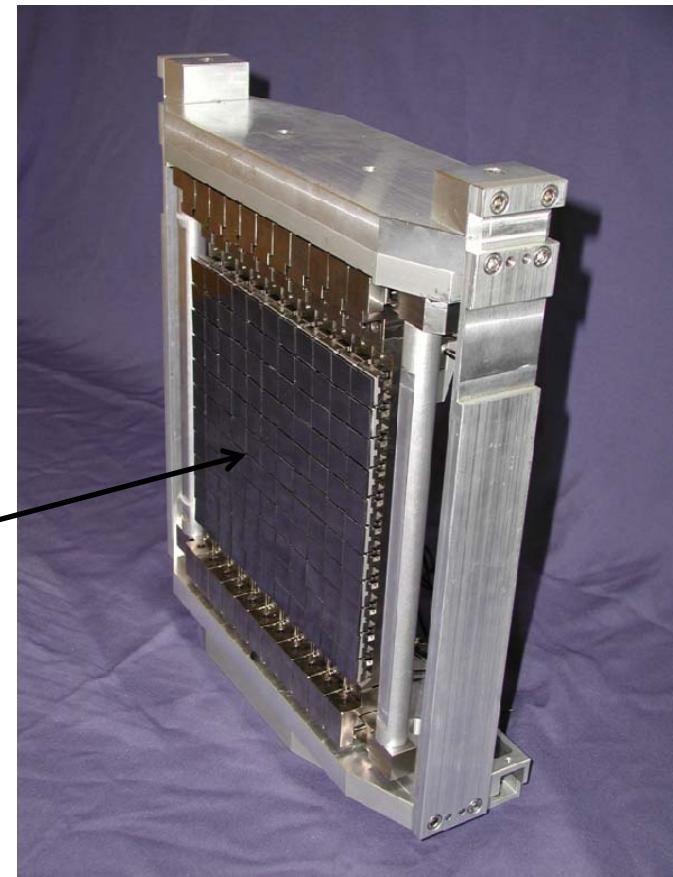
UA: M. Schreck, M. Fischer

New material:

DOI mosaic crystals with well
defined mosaic spread of 0.2° to 0.5°



DOI sample to replace standard HOPG
element ($1.5 \times 1.5 \times 0.15 \text{ cm}^3$, 6 ct)

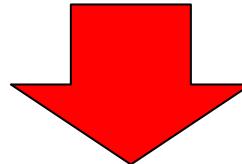


The HOPG-monochromator of PANDA with 121
individual adjustable elements ($2 \times 2 \times 0.2 \text{ cm}^3$)
(priv. comm. G. Borchert, FRM II)

CARAT results from diamond-on-iridium (DOI) sensors

CARAT CONCLUSION

UNEXPECTED RAPID PROGRESS
OF SAMPLE QUALITY



DOI DIAMOND TOWARDS
LARGE-AREA
'SPECTROSCOPIC-GRADE' CVD DOI !